

# NTPF600N80S3Z-VB Datasheet N-Channel 800V (D-S) Super Junction Power MOSFET

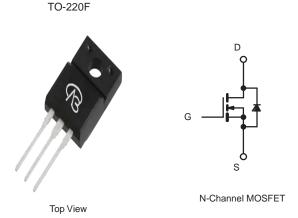
| PRODUCT SUMM                               | ARY                    |       |
|--|------------------------|-------|
| V <sub>DS</sub> (V) at T <sub>J</sub> max. | 800                    | 0     |
| R <sub>DS(on)</sub> at 25 °C (Ω)           | V <sub>GS</sub> = 10 V | 0.540 |

#### **FEATURES**

- Low figure-of-merit (FOM) Ron x Qg
- Low input capacitance (Ciss)
- Reduced switching and conduction losses
- Ultra low gate charge (Q<sub>a</sub>)
- Avalanche energy rated (UIS)

#### **APPLICATIONS**

- Server and telecom power supplies
- Switch mode power supplies (SMPS)
- Power factor correction power supplies (PFC)
- - High-intensity discharge (HID)
  - Fluorescent ballast lighting
- Industrial



| <b>ABSOLUTE MAXIMUM RATINGS</b> (T <sub>C</sub> = 25 °C, unless otherwise noted) |                         |   |                                   |             |         |  |  |
|--|-------------------------|---|-----------------------------------|-------------|---------|--|--|
| PARAMETER  |                         |   | SYMBOL                            | LIMIT       | UNIT    |  |  |
| Drain-Source Voltage   |                         |   | $V_{DS}$                          | 800         | V       |  |  |
| Gate-Source Voltage  |                         |   | $V_{GS}$                          | ± 30        | <b></b> |  |  |
| Continuous Drain Current (T <sub>J</sub> = 150 °C)                               | V <sub>GS</sub> at 10 V | $T_{\rm C} = 25  ^{\circ}{\rm C}$<br>$T_{\rm C} = 100  ^{\circ}{\rm C}$ | - I <sub>D</sub>                  | 9           |         |  |  |
|  | VGS at 10 V             | T <sub>C</sub> = 100 °C   |                                   | 5           | Α       |  |  |
| Pulsed Drain Current <sup>a</sup>  |                         |   | I <sub>DM</sub>                   | 27          |         |  |  |
| Linear Derating Factor   |                         |   |                                   | 1.67        | W/°C    |  |  |
| Single Pulse Avalanche Energy b  |                         |   | E <sub>AS</sub>                   | 515         | mJ      |  |  |
| Maximum Power Dissipation  |                         |   | $P_{D}$                           | 301         | W       |  |  |
| Operating Junction and Storage Temperature Range                                 |                         |   | T <sub>J</sub> , T <sub>stg</sub> | -55 to +150 | °C      |  |  |
| Drain-Source Voltage Slope   | T <sub>J</sub> = 125 °C |   | -1\//-1+                          | 50          | \//     |  |  |
| Reverse Diode dV/dt <sup>d</sup>   |                         | dV/dt   | 15                                | - V/ns      |         |  |  |
| Soldering Recommendations (Peak Temperature) c                                   | for                     | 10 s  |                                   | 260         | °C      |  |  |

- a. Repetitive rating; pulse width limited by maximum junction temperature. b.  $V_{DD}=100$  V, starting  $T_{J}=25$  °C, L = 28.2 mH,  $R_{g}=25$   $\Omega$ ,  $I_{AS}=5$ A.
- c. 1.6 mm from case.
- d.  $I_{SD} \le I_D$ , dI/dt = 100 A/ $\mu$ s, starting  $T_J = 25$  °C.



| THERMAL RESISTANCE RATI          | NGS               |      |      |      |
|----------------------------------|-------------------|------|------|------|
| PARAMETER                        | SYMBOL            | TYP. | MAX. | UNIT |
| Maximum Junction-to-Ambient      | R <sub>thJA</sub> | -    | 62   | °C/W |
| Maximum Junction-to-Case (Drain) | R <sub>thJC</sub> | -    | 0.7  | C/VV |

| PARAMETER   | SYMBOL                | TES   | MIN.   | TYP. | MAX.  | UNIT  |      |
|---|-----------------------|---|--|------|-------|-------|------|
| Static  |                       | •   |  | •    | •     |       |      |
| Drain-Source Breakdown Voltage                            | V <sub>DS</sub>       | V <sub>GS</sub> :   | = 0 V, I <sub>D</sub> = 1 mA                     | 800  | -     | -     | V    |
| V <sub>DS</sub> Temperature Coefficient                   | $\Delta V_{DS}/T_{J}$ | Reference   | e to 25 °C, I <sub>D</sub> = 1 mA                | -    | 0.70  | -     | V/°C |
| Gate-Source Threshold Voltage (N)                         | V <sub>GS(th)</sub>   | V <sub>DS</sub> =   | = V <sub>GS</sub> , I <sub>D</sub> = 250 μA      | 2.5  | -     | 4.5   | V    |
|   |                       |   | V <sub>GS</sub> = ± 20 V                         | -    | -     | ± 100 | nA   |
| Gate-Source Leakage                                       | I <sub>GSS</sub>      |   | V <sub>GS</sub> = ± 30 V                         | -    | -     | ± 1   | μΑ   |
|   |                       | V <sub>DS</sub> =   | = 800V, V <sub>GS</sub> = 0 V                    | -    | -     | 1     |      |
| Zero Gate Voltage Drain Current                           | I <sub>DSS</sub>      | V <sub>DS</sub> = 640V  | , V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C | -    | -     | 100   | μA   |
| Drain-Source On-State Resistance                          | R <sub>DS(on)</sub>   | V <sub>GS</sub> = 10 V  |  | -    | 0.540 | -     | Ω    |
| Forward Transconductance                                  | 9fs                   | V <sub>DS</sub>   | s = 30 V, I <sub>D</sub> =3 A                    | -    | 5.6   | -     | S    |
| Dynamic   |                       | ,   |  |      |       |       |      |
| Input Capacitance   | C <sub>iss</sub>      | $V_{GS} = 0 \text{ V},$ $V_{DS} = 100 \text{ V},$ $f = 1 \text{ MHz}$   |  | -    | 2600  | -     | pF   |
| Output Capacitance  | Coss                  |   |  | -    | 80    | -     |      |
| Reverse Transfer Capacitance                              | C <sub>rss</sub>      |   |  | -    | 4     | -     |      |
| Effective Output Capacitance, Energy Related <sup>a</sup> | C <sub>o(er)</sub>    | - V <sub>DS</sub> = 0 V to 520 V, V <sub>GS</sub> = 0 V   |  | -    | 63    | -     |      |
| Effective Output Capacitance, Time Related <sup>b</sup>   | C <sub>o(tr)</sub>    |   |  | -    | 213   | -     |      |
| Total Gate Charge   | Qg                    |   |  | -    | 81    | -     |      |
| Gate-Source Charge  | Q <sub>gs</sub>       | $V_{GS} = 10 \text{ V}$   | $I_D = 5 A, V_{DS} = 520 V$                      | -    | 15    | -     | nC   |
| Gate-Drain Charge   | $Q_{gd}$              |   |  | -    | 19    | -     |      |
| Turn-On Delay Time  | $t_{d(on)}$           |   |  | -    | 18    | 25    |      |
| Rise Time   | t <sub>r</sub>        | $V_{DD} = 520 \text{ V}, I_D = 5 \text{ A}, V_{GS} = 10 \text{ V}, R_g = 9.1 \Omega$                            |  | -    | 24    | 55    | ns   |
| Turn-Off Delay Time                                       | t <sub>d(off)</sub>   |   |  | -    | 8 0   | -     |      |
| Fall Time   | t <sub>f</sub>        |   |  | -    | 12    | -     |      |
| Gate Input Resistance                                     | $R_{g}$               | f = 1 MHz, open drain   |  | -    | 0.8   | -     | Ω    |
| <b>Drain-Source Body Diode Characteristic</b>             | s                     |   |  |      |       |       |      |
| Continuous Source-Drain Diode Current                     | I <sub>S</sub>        | MOSFET symbol showing the   |  | -    | -     | 9     |      |
| Pulsed Diode Forward Current                              | I <sub>SM</sub>       | integral revers<br>p - n junction   |  | -    | -     | 27    | - A  |
| Diode Forward Voltage                                     | V <sub>SD</sub>       | T <sub>J</sub> = 25 °   | C, I <sub>S</sub> = 5 A, V <sub>GS</sub> = 0 V   | -    | -     | 1.5   | V    |
| Reverse Recovery Time                                     | t <sub>rr</sub>       | -   |  | -    | 475   | -     | ns   |
| Reverse Recovery Charge                                   | Q <sub>rr</sub>       | T <sub>J</sub> = 25 °C, $I_F = I_S = 5 \text{ A}$ , $dI/dt = 100 \text{ A/}\mu\text{s}$ , $V_R = 400 \text{ V}$ |  | -    | 5.8   | -     | μC   |
| Reverse Recovery Current                                  | I <sub>RBM</sub>      |   |  | _    | 33    | _     | A    |

#### Notes

- a.  $C_{oss(er)}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ . b.  $C_{oss(tr)}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 % to 80 %  $V_{DSS}$ .



#### TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

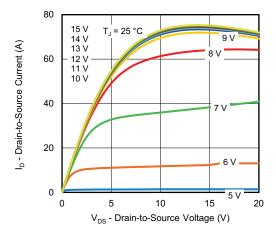


Fig. 1 - Typical Output Characteristics

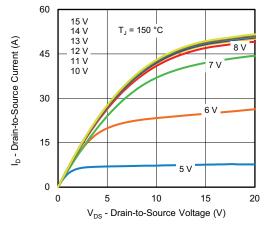


Fig. 2 - Typical Output Characteristics

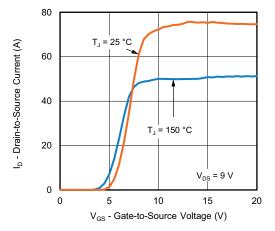


Fig. 3 - Typical Transfer Characteristics

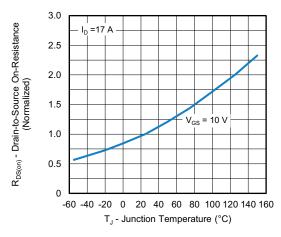


Fig. 4 - Normalized On-Resistance vs. Temperature

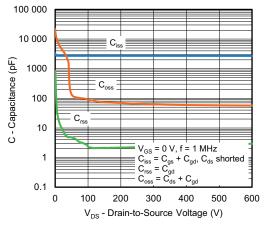


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

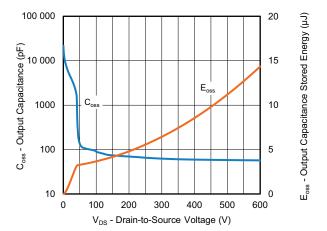


Fig. 6 - Coss and Eoss vs. VDS



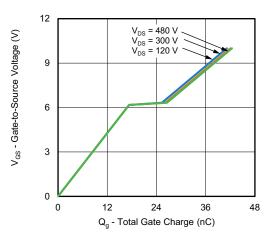


Fig. 7 - Typical Gate Charge vs. Gate-to-Source Voltage

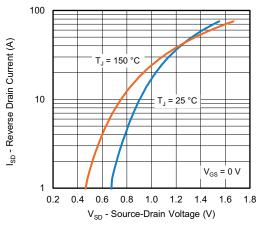


Fig. 8 - Typical Source-Drain Diode Forward Voltage

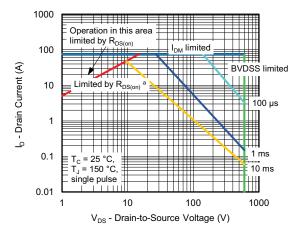


Fig. 9 - Maximum Safe Operating Area

#### Note

a.  $V_{GS} > minimum \ V_{GS}$  at which  $R_{DS(on)}$  is specified

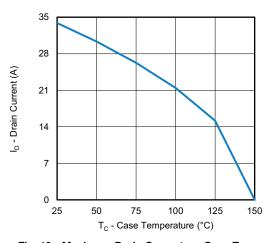


Fig. 10 - Maximum Drain Current vs. Case Temperature

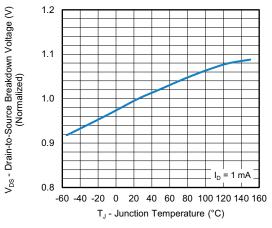


Fig. 11 - Temperature vs. Drain-to-Source Voltage



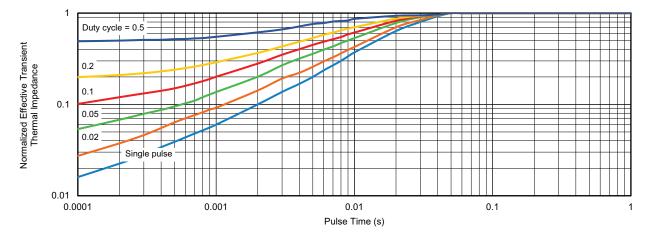


Fig. 12 - Normalized Transient Thermal Impedance, Junction-to-Case

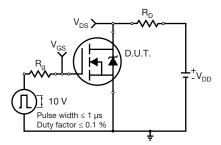


Fig. 13 - Switching Time Test Circuit

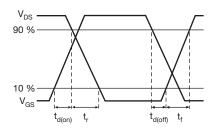


Fig. 14 - Switching Time Waveforms

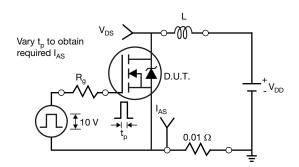


Fig. 15 - Unclamped Inductive Test Circuit

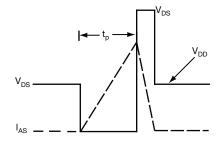


Fig. 16 - Unclamped Inductive Waveforms

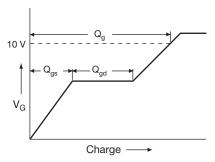


Fig. 17 - Basic Gate Charge Waveform

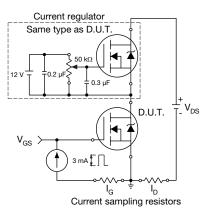


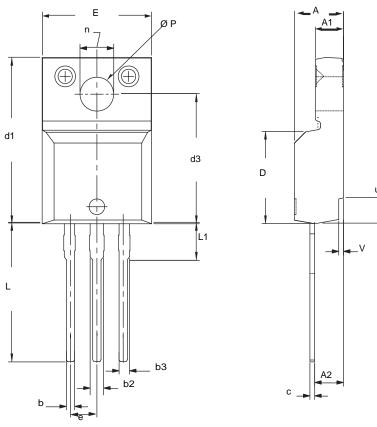
Fig. 18 - Gate Charge Test Circuit

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### **TO-220 FULLPAK (HIGH VOLTAGE)**



| DIM. | MILLIMETERS |        | INCHES |       |
|------|-------------|--------|--------|-------|
|      | MIN.        | MAX.   | MIN.   | MAX.  |
| Α    | 4.570       | 4.830  | 0.180  | 0.190 |
| A1   | 2.570       | 2.830  | 0.101  | 0.111 |
| A2   | 2.510       | 2.850  | 0.099  | 0.112 |
| b    | 0.622       | 0.890  | 0.024  | 0.035 |
| b2   | 1.229       | 1.400  | 0.048  | 0.055 |
| b3   | 1.229       | 1.400  | 0.048  | 0.055 |
| С    | 0.440       | 0.629  | 0.017  | 0.025 |
| D    | 8.650       | 9.800  | 0.341  | 0.386 |
| d1   | 15.88       | 16.120 | 0.622  | 0.635 |
| d3   | 12.300      | 12.920 | 0.484  | 0.509 |
| E    | 10.360      | 10.630 | 0.408  | 0.419 |
| е    | 2.54        | BSC    | 0.100  | BSC   |
| L    | 13.200      | 13.730 | 0.520  | 0.541 |
| L1   | 3.100       | 3.500  | 0.122  | 0.138 |
| n    | 6.050       | 6.150  | 0.238  | 0.242 |
| ØΡ   | 3.050       | 3.450  | 0.120  | 0.136 |
| u    | 2.400       | 2.500  | 0.094  | 0.098 |
| V    | 0.400       | 0.500  | 0.016  | 0.020 |

#### Notes

- To be used only for process drawing.
   These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.3
   All critical dimensions should C meet C<sub>pk</sub> > 1.33.
   All dimensions include burrs and plating thickness.

- 5. No chipping or package damage.



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